Charge partitioning of the intrinsic HBT according to the TICCR

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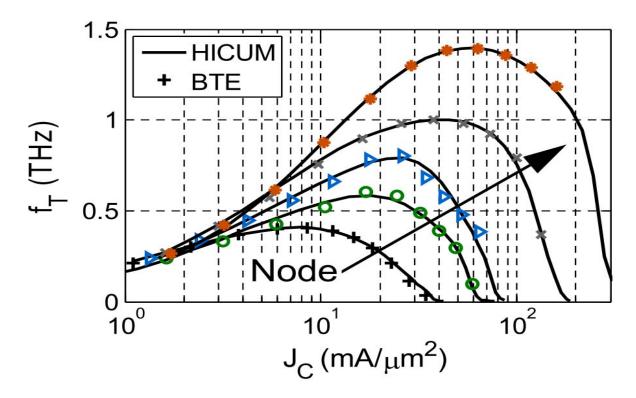
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Introduction

Motivation of this work



Modeling in the terahertz gap?

Predictions of dynamic behavior of charges on physical basis necessary!

[1] M. Schröter, T. Rosenbaum, P. Chevalier, B. Heinemann, S. P. Voinigescu, E. Preisler, J. Böck, and A. Mukherjee, "SiGe HBT technology: Future trends and TCAD-based roadmap", Proc. of the IEEE, vol. 105, no. 6, pp. 1068-1086, 2017.

The Transient Integral Charge-Control Relation (TICCR)

TICCR [2] yields closed-form analytical solution for 1D current densities:

$$j_C(t) = j_T(t) - q \int_0^{x_{bl}} \eta_C \left(R + \frac{\partial n}{\partial t}\right) dx$$

$$j_E(t) = j_T(t) + q \int_0^{x_{bl}} \eta_E \left(R + \frac{\partial n}{\partial t}\right) dx$$

common transfer current component equal to GICCR (except for h_f)

$$j_{T}(t) = qV_{T}\mu_{nr}n_{ir}^{2} \frac{\exp\left(\frac{v_{B'E'}}{V_{T}}\right) - \exp\left(\frac{v_{B'C'}}{V_{T}}\right)}{\int_{0}^{x_{bl}} h_{v}h_{g}p dx}$$

=> can be directly applied to HICUM

=> Focus here on time dependent terms of TICCR current density

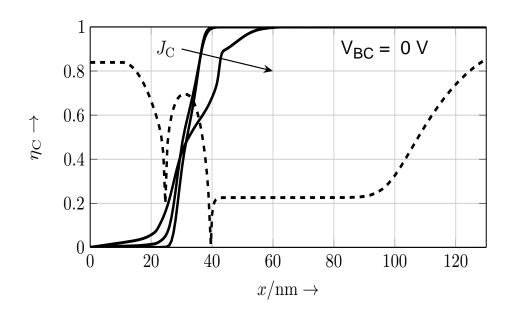
[2] H. Klose and A. Wieder, "The transient integral charge control relation: A novel formulation of the currents in a bipolar transistor," IEEE Trans. Electron Dev., vol. 34, no. 5, pp. 1090-1099, 1987.

Charge partitioning

partitioning functions:

$$\eta_C(t) = \frac{\int_0^x h_v h_g p d\xi}{\int_0^{x_{bl}} h_v h_g p dx}$$

$$\eta_E(t) = 1 - \eta_C$$



with GICCR weight functions

$$h_{v}(t) = \exp\left(\frac{v_{B'E'}(t) - \varphi_{p}(x, t)}{V_{T}}\right). \quad h_{g}(t) = \frac{\mu_{nr}n_{ir}^{2}}{\mu_{n}(x, t)n_{i}^{2}(x)}$$

=> η_C (η_E) determines fraction of charge that is supported by C (E) terminal during dynamic operation

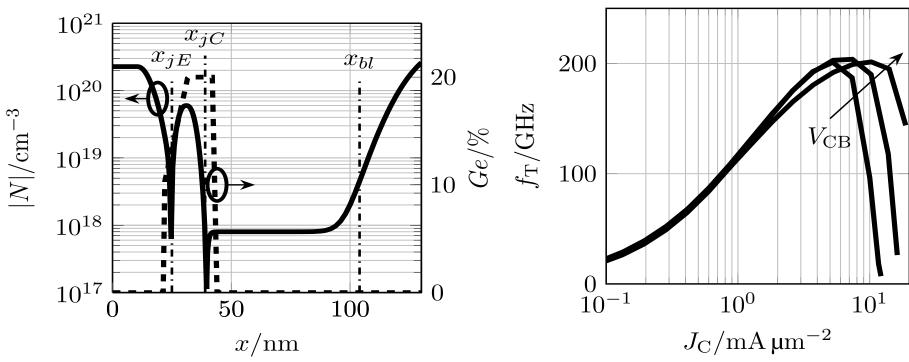
ullet weak bias dependence up to medium $J_{\mathbb{C}}$

Selected transistor structure



10^{21}

transit frequency



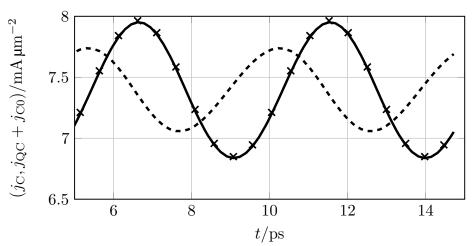
- Integration limits of the TICCR according to [3]
- DD transport dominant
 - for more advanced structures => use augmented DD transport

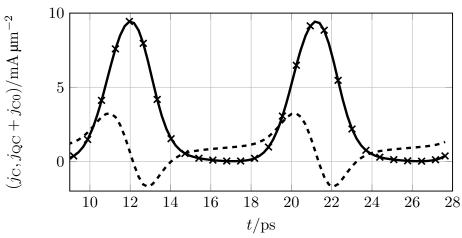
M. Schroter, S. Lehmann, and A. Pawlak, "Why is there no internal collector resistance in HICUM?", IEEE Bipolar/BiCMOS Circ. and Technol. Meeting (BCTM), pp. 142-145, 2016.

Comparison of TICCR with device simulation

- sinusoidal monofrequent input signal with frequency f
- small-signal operation
 - OP: $(J_C, V_{BC}) = (7.39 \text{ mA/}\mu\text{m}^2, 0\text{V})$ => peak f_T
 - $f = 203 \text{ GHz} (= \text{peak } f_T)$
 - 2.5 mV V_{BE} amplitude
- large-signal operation
 - OP: $(J_C, V_{BC}) = (1.26 \text{ mA/}\mu\text{m}^2, 0 \text{ V})$
 - $f = f_T = 131 \text{ GHz}$
 - 70 mV V_{BE} amplitude

$$=> \max_{t} j_{C}(t) = 1.5 J_{C}(f_{T,peak}) !$$





excellent agreement for small-signal and large-signal case
 reference for compact model related simplifications

Compact modeling approach

Simplifications of TICCR charge description

Assumptions

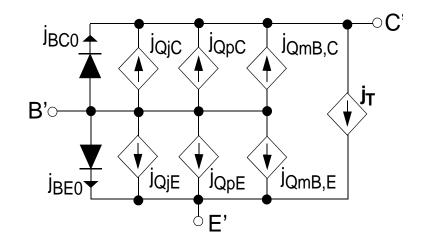
- quasi-static carrier distribution => charge, GICCR
- negligible recombination => collector charging current density:

$$j_{QC} = q \int_0^{x_{bl}} \eta_C \frac{\partial n}{\partial t} dx$$

• η_C = 1 for BC region => components

$$j_{QjC} = \frac{\partial \overline{Q}_{jC}}{\partial t} = q \int_{x_{jC}}^{x_{bl}} \frac{\partial (\Delta n - \Delta p)}{\partial t} dx$$

$$j_{QpC} = \frac{\partial \overline{Q}_{pC}}{\partial t} = q \int_{x_{iC}}^{x_{bl}} \frac{\partial \Delta p}{\partial t} dx$$

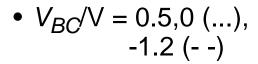


• assume $\eta_C = \eta_{mB} < 1$ for base region only:

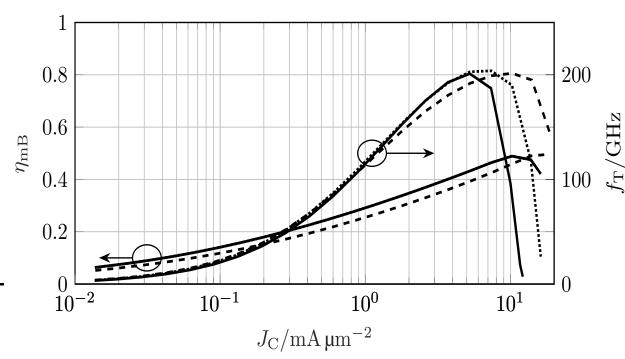
$$j_{QmB, C} = \eta_{mB} \frac{\partial \overline{Q}_{mB}}{\partial t}$$
 with $\eta_{mB} = \int_{x_{jE}}^{x_{jC}} \eta_C \Delta n dx / \int_{x_{jE}}^{x_{jC}} \Delta n dx$

Base charge partitioning factor

$$\eta_{mB} = \frac{\int_{x_{jE}}^{x_{jC}} \eta_{C} \Delta n dx}{\int_{x_{jE}}^{x_{jC}} \Delta n dx}$$



f_τ curve added for reference

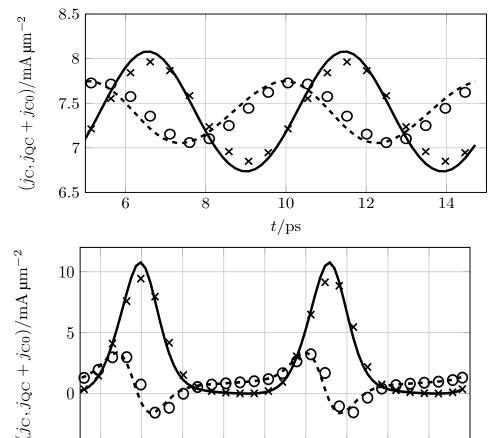


 $=>\eta_{\rm mB}$ depends on $J_{\rm C}$, but only slight function of $V_{\rm BC}$

- analytical formulation for bias dependence yet to be developed
 - excess phase shift = atan($\omega \eta_{mB} C_{dE}/g_m$) = atan($\omega \eta_{mB} \tau_f$) => $\eta_{mB} = \alpha_{IT}$
- existing compact models use bias independent partitioning factor (e.g. fixed value 1/3 in MEXTRAM)

Comparison to device simulation

- monofrequent sinusoidal input signal with frequency f => same conditions as before
- small-signal operation: model ...
 - amplidute higher
 - phase shifts
- large-signal operation: model ...
 - amplitude overshoot
 - phase shift during turn-off
- causes for deviations?
 - dynamic ic component phase shift
 - other?



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16

18

t/ps

20

22

24

26

28

14

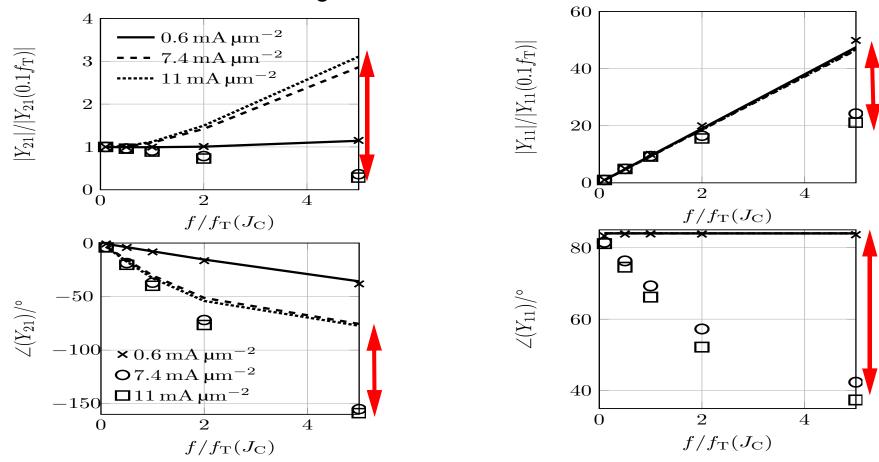
=> charge partitioning alone is not sufficient for accurately capturing dynamic collector terminal currant!

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Frequency domain results

...indicating cause of observed deviations

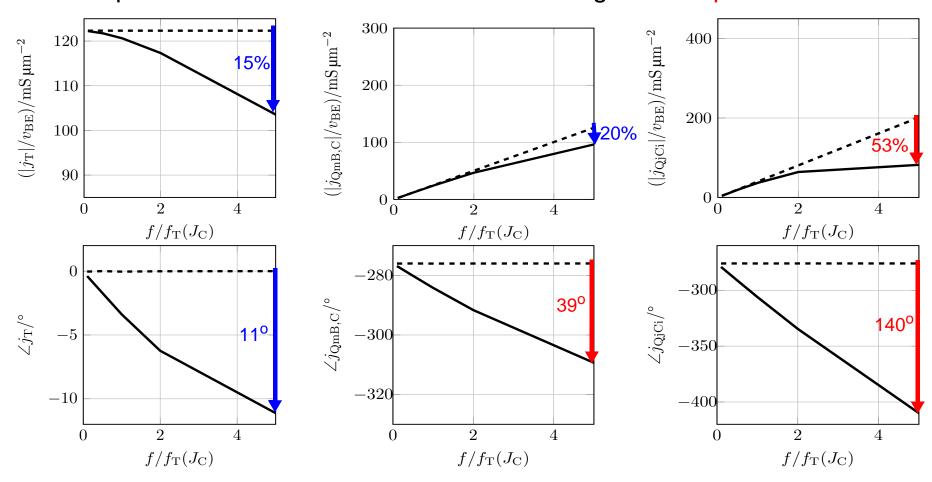


accurate at low forward bias, but significant deviations at high bias

=> charge partitioning misses phase shift in *mobile* charge!

Deviations at higher harmonics

comparison of TCAD vs. CP model with charges from q.s. simulation



- relatively weak frequency dependence of transfer current
- significant frequency dep. of BC depletion charge (SCR modulation!)

Summary

- TICCR offers exact solution of drift-diffusion-based charging currents
 use as reference for 1D compact model development
- Using quasi-static charges, TICCR based charge-partitioning shows high accuracy up to $f_{T,1D}$, but large deviations for harmonics from 2 $f_{T,1D}$ on
- Base charge partitioning factor depends on J_T
 - => charge-partitioning model must include phases of charges!

Outlook

- Measurements of HV devices to validate predictions experimentally
- Develop (i) bias dependent base charge partitioning factor and
 (ii) representation of additional phase shift in BC depletion current
- Replace gyrator adjunct EC in HICUM by new analytical charge partitioning
 allows to delete two nodes

=> runtime reduction!

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